

Notice of References Cited	Application/Control No. 10/669,496	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,550,044	04-2003	Pavisc et al.	716/6
	B	US-5,963,728	10-1999	Hathaway et al.	716/3
	C	US-6,189,131	02-2001	Graef et al.	716/8
	D	US-6,099,584	08-2000	Arnold et al.	716/19
	E	US-6,523,155	02-2003	Ruedinger, Jeffrey Joseph	716/7
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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